



P-Channel 30 V (D-S) MOSFET

PRODUC	CT SUMMARY		
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A)	Q _g (Typ.)
- 30	0.020 at V _{GS} = - 10 V	- 12 ^a	15.5 nC
- 30	0.033 at $V_{GS} = -4.5 \text{ V}$	- 12 ^a	15.5 110

FEATURES

 Halogen-free According to IEC 61249-2-21 Definition

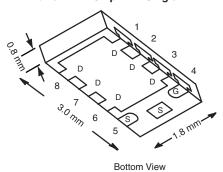


- New Thermally Enhanced PowerPAK[®] ChipFET[®] Package
 - Small Footprint Area
 - Low On-Resistance
 - Thin 0.8 mm profile
- Compliant to RoHS Directive 2002/95/EC



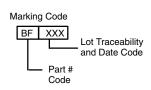
ROHS COMPLIANT HALOGEN FREE

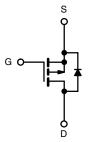
PowerPAK® ChipFET® Single



APPLICATIONS

Load Switch





P-Channel MOSFET

Ordering Information: Si5419DU-T1-GE3 (Lead (Pb)-free and Halogen-free)

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	- 30	V	
Gate-Source Voltage		V _{GS}	± 20		
	T _C = 25 °C		- 12 ^a		
Continuous Drain Current (T _{.1} = 150 °C)	$T_C = 70 ^{\circ}C$	I _D	- 12 ^a		
Continuodo Brain Carrein (1) = 100 °C)	T _A = 25 °C	ן טי [- 9.9 ^{b, c}		
	T _A = 70 °C	1	- 7.9 ^{b, c}	A	
Pulsed Drain Current		I _{DM}	- 40		
Continuous Source-Drain Diode Current	T _C = 25 °C		- 12 ^a		
Continuous Source-Diam Diode Current	T _A = 25 °C	Is	- 2.6 ^{b, c}		
	T _C = 25 °C		31		
Maximum Power Dissipation	T _C = 70 °C	P _D	20	W	
Maximum Fower Dissipation	T _A = 25 °C		3.1 ^{b, c}	VV	
	T _A = 70 °C	1 [2 ^{b, c}		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C	
Soldering Recommendations (Peak Temperature) ^{d, e}			260		

THERMAL RESISTANCE RAT	RMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, f}	t ≤ 5 s	R _{thJA}	34	40	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R_{thJC}	3	4	C/ VV	

Notes:

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 5 s
- d. See solder profile (www.vishay.com/ppg?73257). The PowerPAK ChipFET is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state conditions is 90 °C/W.



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static						<u> </u>
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = - 250 μA	- 30			V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$			- 20		
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = - 250 μA		5		mV/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_{D} = -250 \mu A$	- 1.2		- 2.5	V
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
Zara Oaka Walkara Burin Oamani	I _{DSS}	V _{DS} = - 30 V, V _{GS} = 0 V			- 1	
Zero Gate Voltage Drain Current		V _{DS} = - 30 V, V _{GS} = 0 V, T _J = 55 °C			- 5	μΑ
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le -5 \text{ V}, V_{GS} = -4.5 \text{ V}$ - 20				Α
Drain-Source On-State Resistance ^a		V _{GS} = - 10 V, I _D = - 6.6 A		0.016	0.020	_
	R _{DS(on)}	V _{GS} = - 4.5 V, I _D = - 5.1 A		0.027	0.033	Ω
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 10 V, I _D = - 6.6 A		20		S
Dynamic ^b						,
Input Capacitance	C _{iss}			1400		
Output Capacitance	C _{oss}	V _{DS} = - 15 V, V _{GS} = 0 V, f = 1 MHz		240		pF
Reverse Transfer Capacitance	C _{rss}			200		
Total Gate Charge	Qg	V _{DS} = - 15 V, V _{GS} = - 10 V, I _D = - 9.9 A		30	45	nC
				15.5	24	
Gate-Source Charge	Q_{gs}	$V_{DS} = -15 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -9.9 \text{ A}$		4.5		
Gate-Drain Charge	Q_{gd}			7.5		
Gate Resistance	R_g	f = 1 MHz		6.7		Ω
Turn-on Delay Time	t _{d(on)}			47	70	
Rise Time	t _r	$V_{DD} = -15 \text{ V}, R_{L} = 1.9 \Omega$		33	50	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong -7.9 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_g = 1 \Omega$		30	45	
Fall Time	t _f			16	25	200
Turn-On Delay Time	t _{d(on)}			10	15	ns
Rise Time	t _r	$V_{DD} = -15 \text{ V}, R_{L} = 1.9 \Omega$		10	15	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong -7.9 \text{ A}, V_{GEN} = -10 \text{ V}, R_g = 1 \Omega$		40	60	
Fall Time	t _f			12	20	
Drain-Source Body Diode Characterist	cs					
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			- 12	A
Pulse Diode Forward Current	I _{SM}				40	_ ^
Body Diode Voltage	V_{SD}	I _S = - 7.9 A, V _{GS} = 0 V		- 0.85	- 1.2	V
Body Diode Reverse Recovery Time	t _{rr}			25	40	ns
Body Diode Reverse Recovery Charge	Q_{rr}	I _F = - 7.9 A, dl/dt = 100 A/μs, T _{.l} = 25 °C		15	25	nC
Reverse Recovery Fall Time	t _a	$_{1}$ $_{1F} = -7.8$ A, $_{3}$ $_{4}$ $_{4}$ $_{5}$ $_{1J} = 25$ $_{5}$		11		ns
Reverse Recovery Rise Time	t _b			14		

Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

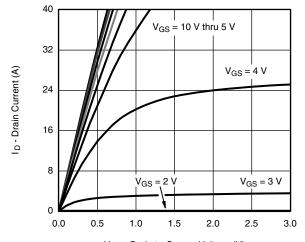
a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%$

a. Guaranteed by design, not subject to production testing.



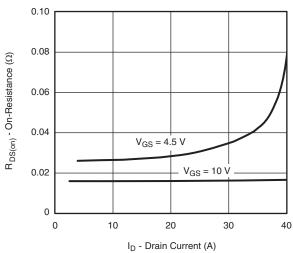


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

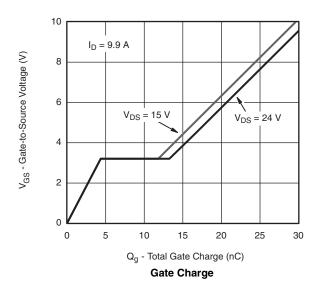


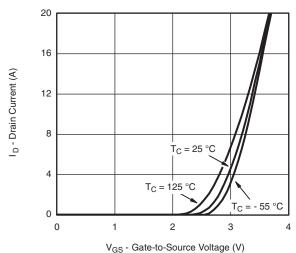
V_{DS} - Drain-to-Source Voltage (V)

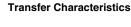
Output Characteristics

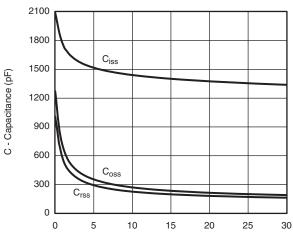


On-Resistance vs. Drain Current



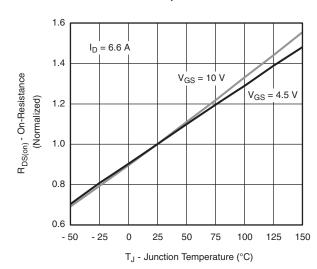






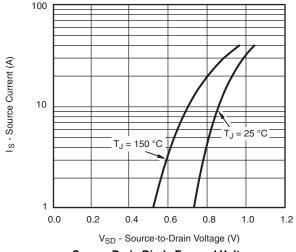
V_{DS} - Drain-to-Source Voltage (V)

Capacitance

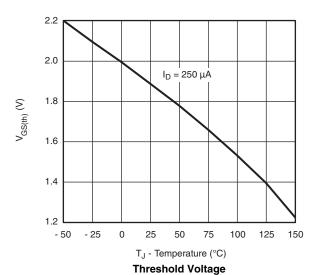


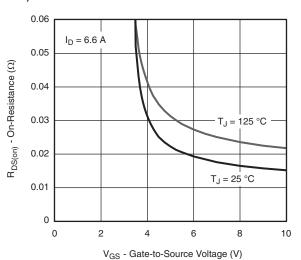
On-Resistance vs. Junction Temperature

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

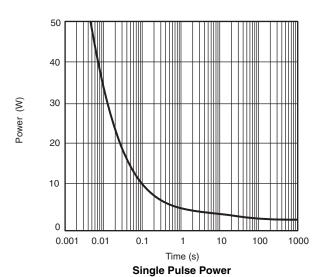


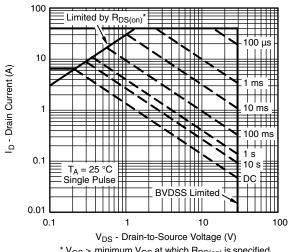
Source-Drain Diode Forward Voltage





On-Resistance vs. Gate-to-Source Voltage





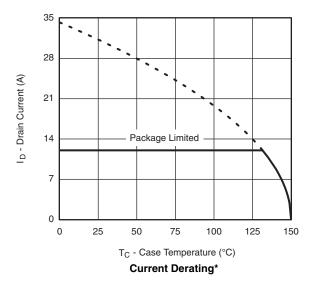
* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

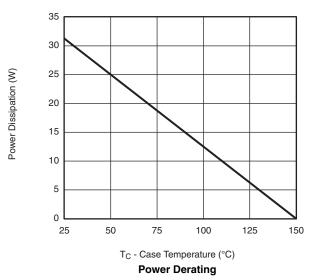
Safe Operating Area





TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

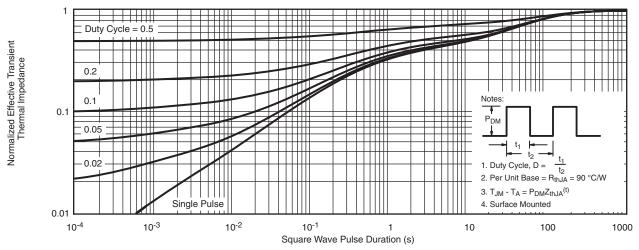




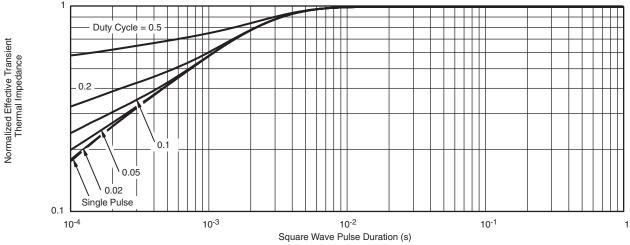
^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient

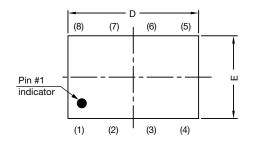


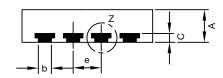
Normalized Thermal Transient Impedance, Junction-to-Case

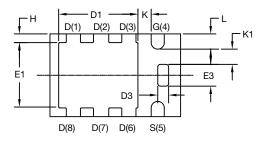
Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?69001.



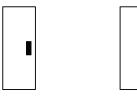
PowerPAK® ChipFET® Case Outline







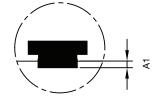
Backside view of single pad



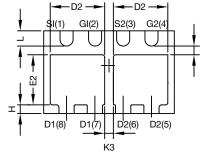
Side view of single



Side view of dual



Detail Z



Backside view of dual pad

DIM.	MILLIMETERS			INCHES		
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.
Α	0.70	0.75	0.85	0.028	0.030	0.033
A1	0	-	0.05	0	-	0.002
b	0.25	0.30	0.35	0.010	0.012	0.014
С	0.15	0.20	0.25	0.006	0.008	0.010
D	2.92	3.00	3.08	0.115	0.118	0.121
D1	1.75	1.87	2.00	0.069	0.074	0.079
D2	1.07	1.20	1.32	0.042	0.047	0.052
D3	0.20	0.25	0.30	0.008	0.010	0.012
E	1.82	1.90	1.98	0.072	0.075	0.078
E1	1.38	1.50	1.63	0.054	0.059	0.064
E2	0.92	1.05	1.17	0.036	0.041	0.046
E3	0.45	0.50	0.55	0.018	0.020	0.022
е		0.65 BSC		0.026 BSC		
Н	0.15	0.20	0.25	0.006	0.008	0.010
K	0.25	-	-	0.010	-	ı
K1	0.30	-	-	0.012	-	ı
K2	0.20	-	-	0.008	-	ı
K3	0.20	-	-	0.008	-	ı
L	0.30	0.35	0.40	0.012	0.014	0.016

C14-0630-Rev. E, 21-Jul-14

Note

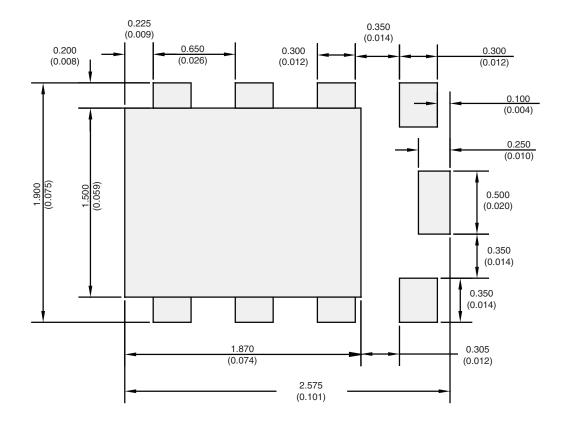
DWG: 5940

Revision: 21-Jul-14

• Millimeters will govern



RECOMMENDED MINIMUM PADS FOR PowerPAK® ChipFET® Single



Recommended Minimum Pads Dimensions in mm/(Inches)

Return to Index

APPLICATION NOTE



Legal Disclaimer Notice

Vishay

Disclaimer

ALL PRODUCT, PRODUCT SPECIFICATIONS AND DATA ARE SUBJECT TO CHANGE WITHOUT NOTICE TO IMPROVE RELIABILITY, FUNCTION OR DESIGN OR OTHERWISE.

Vishay Intertechnology, Inc., its affiliates, agents, and employees, and all persons acting on its or their behalf (collectively, "Vishay"), disclaim any and all liability for any errors, inaccuracies or incompleteness contained in any datasheet or in any other disclosure relating to any product.

Vishay makes no warranty, representation or guarantee regarding the suitability of the products for any particular purpose or the continuing production of any product. To the maximum extent permitted by applicable law, Vishay disclaims (i) any and all liability arising out of the application or use of any product, (ii) any and all liability, including without limitation special, consequential or incidental damages, and (iii) any and all implied warranties, including warranties of fitness for particular purpose, non-infringement and merchantability.

Statements regarding the suitability of products for certain types of applications are based on Vishay's knowledge of typical requirements that are often placed on Vishay products in generic applications. Such statements are not binding statements about the suitability of products for a particular application. It is the customer's responsibility to validate that a particular product with the properties described in the product specification is suitable for use in a particular application. Parameters provided in datasheets and / or specifications may vary in different applications and performance may vary over time. All operating parameters, including typical parameters, must be validated for each customer application by the customer's technical experts. Product specifications do not expand or otherwise modify Vishay's terms and conditions of purchase, including but not limited to the warranty expressed therein.

Except as expressly indicated in writing, Vishay products are not designed for use in medical, life-saving, or life-sustaining applications or for any other application in which the failure of the Vishay product could result in personal injury or death. Customers using or selling Vishay products not expressly indicated for use in such applications do so at their own risk. Please contact authorized Vishay personnel to obtain written terms and conditions regarding products designed for such applications.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted by this document or by any conduct of Vishay. Product names and markings noted herein may be trademarks of their respective owners.